

<b>Notice of References Cited</b>	Application/Control No. 10/798,320	Applicant(s)/Patent Under Reexamination FUKUMOTO ET AL.	
	Examiner Deborah Yee	Art Unit 1742	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,459,162	07-1984	Norstrom et al.	420/106
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2000-328195	11-2000	Japan	Ozaki, Kozo	c22c 38/00
	O	2001-123247	05-2001	Japan	Kurata, Seiji et al	c22c 38/00
	P	2003-55747	02-2003	Japan	Yoshimoto, Takashi et al	c22c 38/00
	Q	1-152242	06-1989	Japan	Tsujii, Nobuhiro et al	c22c 38/36
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.